

Notice of References Cited

Application/Control No.

10/577,670

Applicant(s)/Patent Under

Reexamination

CHEN ET AL.

Examiner

JOSEPH DEAN, JR

Art Unit

2617

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0156558	08-2003	Cromer et al.	370/331
	B	US-			
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	D	US-			
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FOREIGN PATENT DOCUMENTS

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